

Search Notes

Application/Control No.

10/067,981

Examiner

Jacob Meek

Applicant(s)/Patent under
Reexamination

OHSAWA, SUSUMU

Art Unit

2637

SEARCHED

Class	Subclass	Date	Examiner
375	347,267 260	5/26/2005	jm
455	273,137	5/26/2005	JM
455	45,134	5/26/2005	JM
455	277.1,456	5/26/2005	JM
455	277.2,135	5/26/2005	JM
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455	65,506,61	5/26/2005	JM
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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	5/26/2005	JM